

MOSFET – N-Channel QFET®

600 V, 0.3 A, 11.5 Ω

FQN1N60C

Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 0.3 A, 600 V, $R_{DS(on)} = 11.5 \Omega$ (Max.) @ $V_{GS} = 10 V$, $I_D = 0.15 A$
- Low Gate Charge (Typ. 4.8 nC)
- Low C_{rss} (Typ. 3.5 pF)
- 100% Avalanche Tested

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ C$ unless otherwise noted)

| Symbol | Parameter | Value | Unit |
|----------------|----------------------------------------------------------------------------------------------------|----------------|-------------------------|
| V_{DSS} | Drain to Source Voltage | 600 | V |
| V_{GSS} | Gate to Source Voltage | ± 30 | V |
| I_D | Drain Current Continuous ($T_C = 25^\circ C$) Continuous ($T_C = 100^\circ C$) | 0.3 0.18 | A |
| I_{DM} | Drain Current – Pulsed (Note 1) | 1.2 | A |
| E_{AS} | Single Pulsed Avalanche Energy (Note 2) | 33 | mJ |
| I_{AR} | Avalanche Current (Note 1) | 0.3 | A |
| E_{AR} | Repetitive Avalanche Energy (Note 1) | 0.3 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | 4.5 | V/ns |
| P_D | Power Dissipation ($T_A = 25^\circ C$) ($T_L = 25^\circ C$) Derate above $25^\circ C$ | 1 3 0.02 | W W W/ $^\circ C$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +150 | $^\circ C$ |
| T_L | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds | 300 | $^\circ C$ |

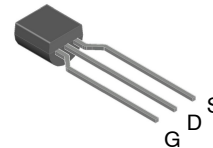
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. $L = 59 mH$, $I_{AS} = 1.1 A$, $V_{DD} = 50 V$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ C$.
3. $I_{SD} \leq 0.3 A$, $di/dt \leq 200 A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ C$.

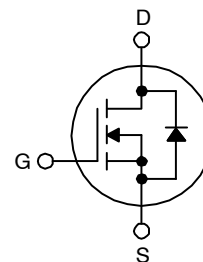


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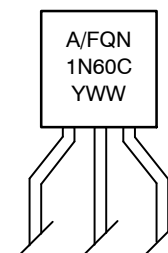
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TO-92 4.75x4.80
CASE 135AV



MARKING DIAGRAM



A = Assembly Site
FQN1N60C = Specific Device Code
Y = Year of Production
WW = Work Week Number

ORDERING INFORMATION

| Device | Package | Shipping |
|------------|-----------|-----------------|
| FQN1N60CTA | TO-92 3LD | 2000 / Fan-Fold |

FQN1N60C

THERMAL CHARACTERISTICS

| Symbol | Parameter | Value | Unit |
|-----------------|--------------------------------------------------------|-------|------|
| $R_{\theta JL}$ | Thermal Resistance, Junction-to-Lead, Max. (Note 5) | 50 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient, Max. (Note 6) | 140 | |

ELECTRICAL CHARACTERISTICS (T_C = 25°C, unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Unit |
|--------------------------------|-------------------------------------------|----------------------------------------|-----|-----|------|---------|
| OFF CHARACTERISTIC | | | | | | |
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 600 | - | - | V |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu A$, Referenced to 25°C | - | 0.6 | - | V/°C |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 600 V, V_{GS} = 0 V$ | - | - | 50 | μA |
| | | $V_{DS} = 480 V, T_C = 125^\circ C$ | - | - | 250 | |
| I_{GSSF} | Gate to Body Leakage Current, Forward | $V_{GS} = 30 V, V_{DS} = 0 V$ | - | - | 100 | nA |
| I_{GSSR} | Gate to Body Leakage Current, Reverse | $V_{GS} = -30 V, V_{DS} = 0 V$ | - | - | -100 | nA |

ON CHARACTERISTICS

| | | | | | | |
|--------------|--------------------------------------|------------------------------------|-----|------|------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 2.0 | - | 4.0 | V |
| $R_{DS(on)}$ | Static Drain to Source On-Resistance | $V_{GS} = 10 V, I_D = 0.15 A$ | - | 9.3 | 11.5 | Ω |
| g_{FS} | Forward Transconductance | $V_{DS} = 40 V, I_D = 0.3 A$ | - | 0.75 | - | S |

DYNAMIC CHARACTERISTICS

| | | | | | | |
|-----------|------------------------------|--------------------------------------------|---|-----|-----|----|
| C_{iss} | Input Capacitance | $V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz$ | - | 130 | 170 | pF |
| C_{oss} | Output Capacitance | | - | 19 | 25 | pF |
| C_{rss} | Reverse Transfer Capacitance | | - | 3.5 | 6 | pF |

SWITCHING CHARACTERISTICS

| | | | | | | |
|--------------|-----------------------|------------------------------------------------------------|---|-----|-----|----|
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 300 V, I_D = 1.1 A, R_G = 25 \Omega$ (Note 4) | - | 7 | 24 | ns |
| t_r | Turn-On Rise Time | | - | 21 | 52 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | - | 13 | 36 | ns |
| t_f | Turn-Off Fall Time | | - | 27 | 64 | ns |
| Q_g | Total Gate Charge | $V_{DS} = 480 V, I_D = 1.1 A, V_{GS} = 10 V$ (Note 4) | - | 4.8 | 6.2 | nC |
| Q_{gs} | Gate to Source Charge | | - | 0.7 | - | nC |
| Q_{gd} | Gate to Drain Charge | | - | 2.7 | - | nC |

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

| | | | | | | |
|----------|----------------------------------------------------------|----------------------------------------------------|---|------|-----|---------|
| I_S | Maximum Continuous Drain to Source Diode Forward Current | - | - | 0.3 | A | |
| I_{SM} | Maximum Pulsed Drain to Source Diode Forward Current | - | - | 1.2 | A | |
| V_{SD} | Drain to Source Diode Forward Voltage | $V_{GS} = 0 V, I_S = 0.3 A$ | - | - | 1.4 | V |
| t_{rr} | Reverse Recovery Time | $V_{GS} = 0 V, I_S = 1.1 A, di_F/dt = 100 A/\mu s$ | - | 190 | - | ns |
| Q_{rr} | Reverse Recovery Charge | | - | 0.53 | - | μC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Essentially independent of operating temperature.
- Reference point of the $R_{\theta JL}$ is the drain lead.
- When mounted on 3"x4.5" FR-4 PCB without any pad copper in a still air environment ($R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance. $R_{\theta CA}$ is determined by the user's board design)

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TYPICAL CHARACTERISTICS

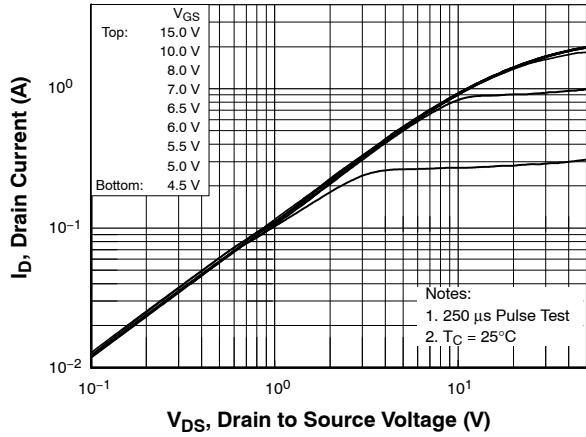


Figure 1. On-Region Characteristics

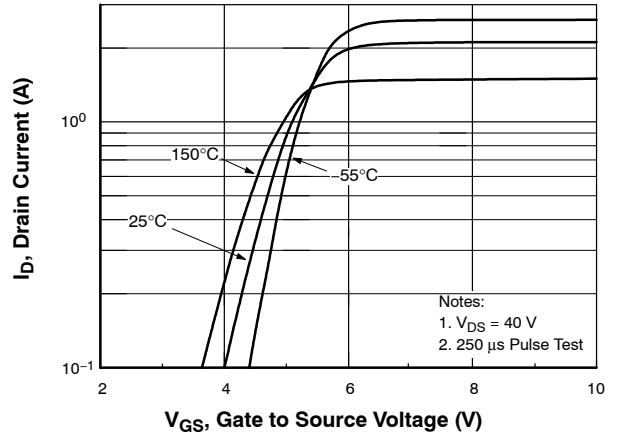


Figure 2. Transfer Characteristics

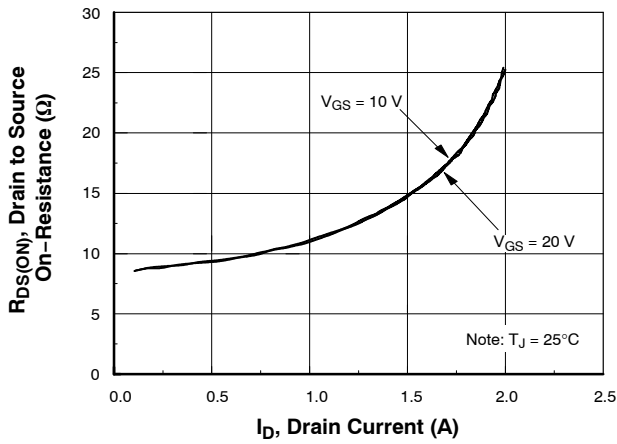


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

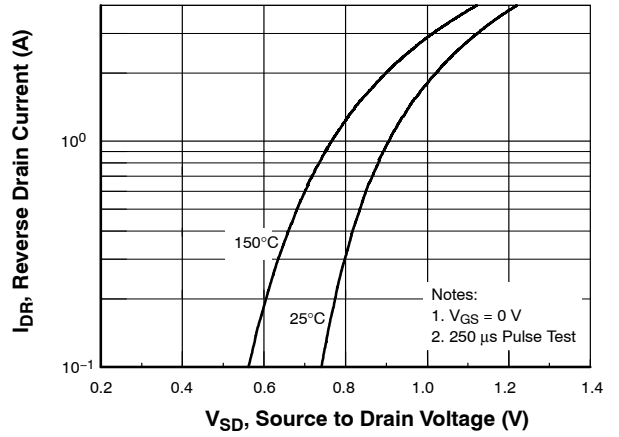


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

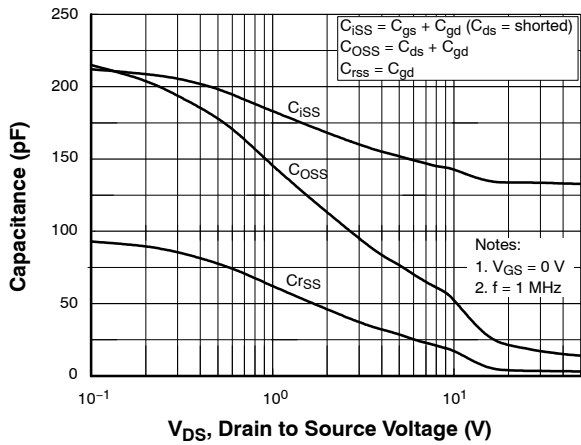


Figure 5. Capacitance Characteristics

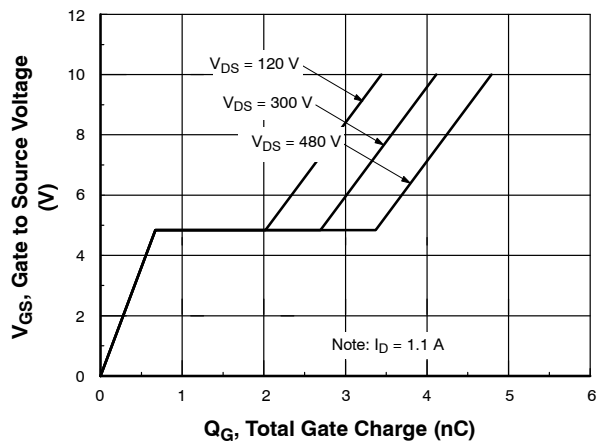


Figure 6. Gate Charge Characteristics

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TYPICAL CHARACTERISTICS (Continued)

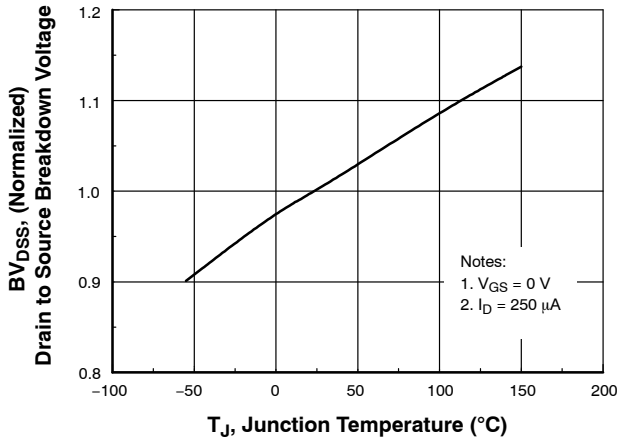


Figure 7. Breakdown Voltage Variation vs. Temperature

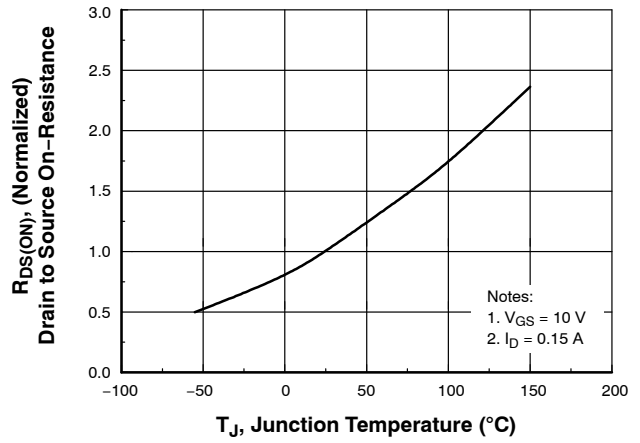


Figure 8. On-Resistance Variation vs. Temperature

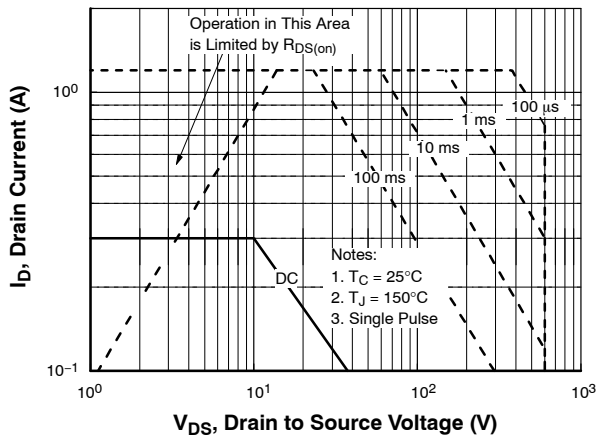


Figure 9. Maximum Safe Operating Area

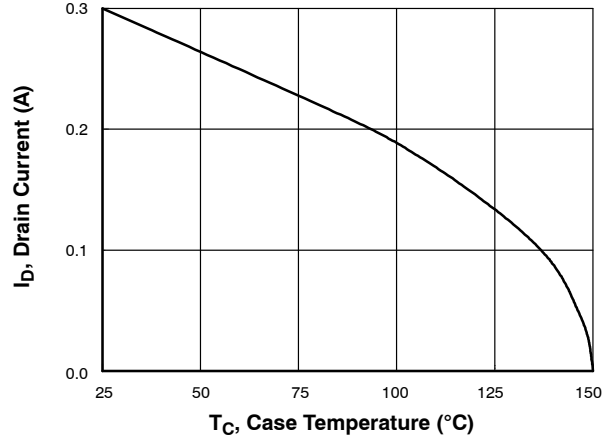


Figure 10. Maximum Drain Current vs. Case Temperature

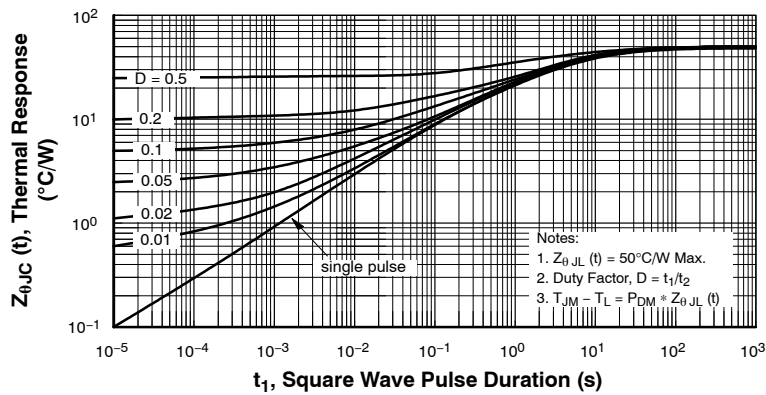


Figure 11. Transient Thermal Response Curve

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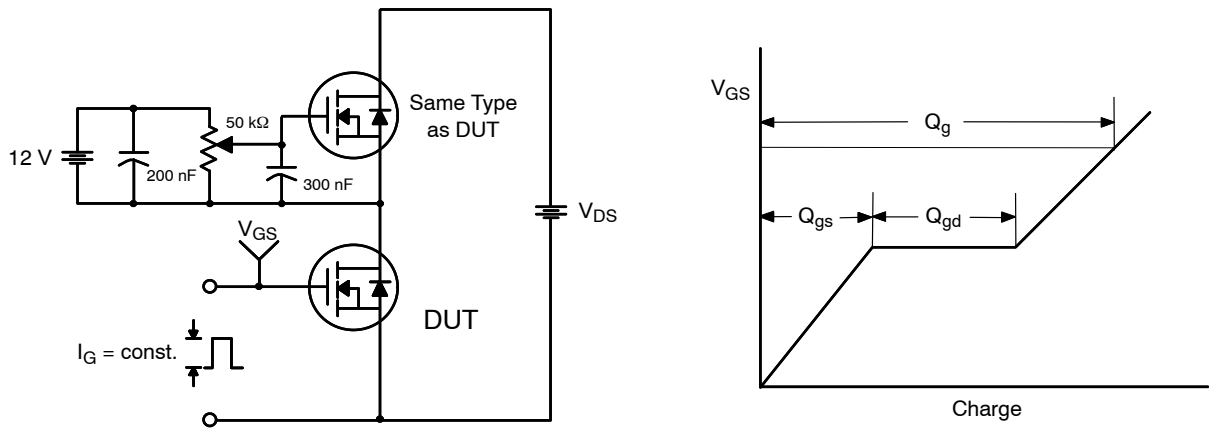


Figure 12. Gate Charge Test Circuit & Waveform

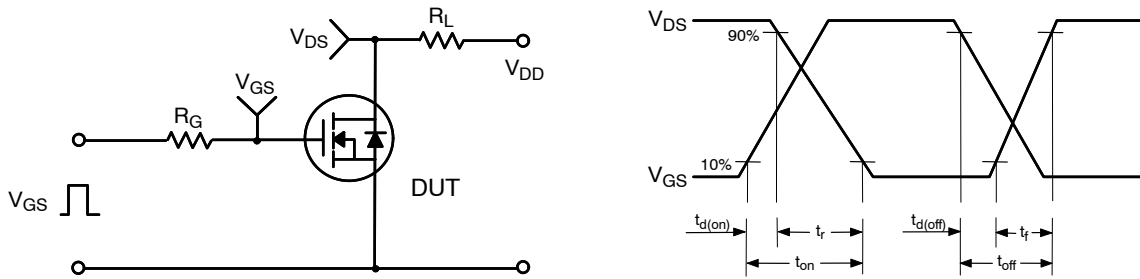


Figure 13. Resistive Switching Test Circuit & Waveforms

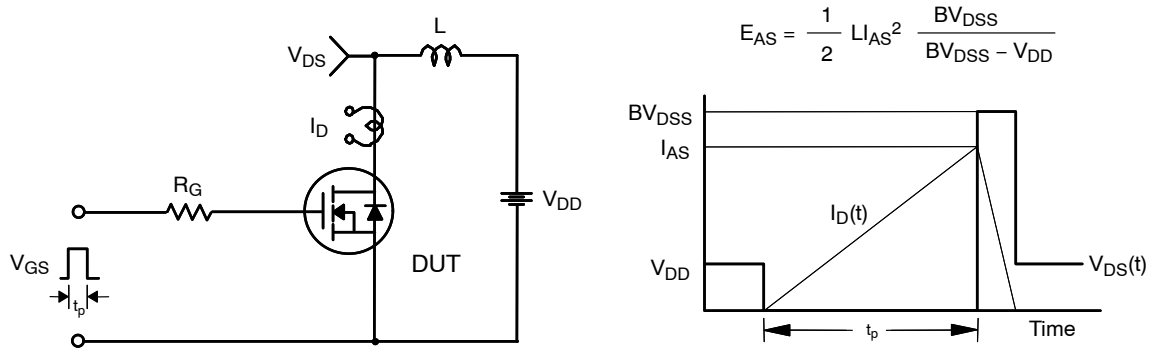


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

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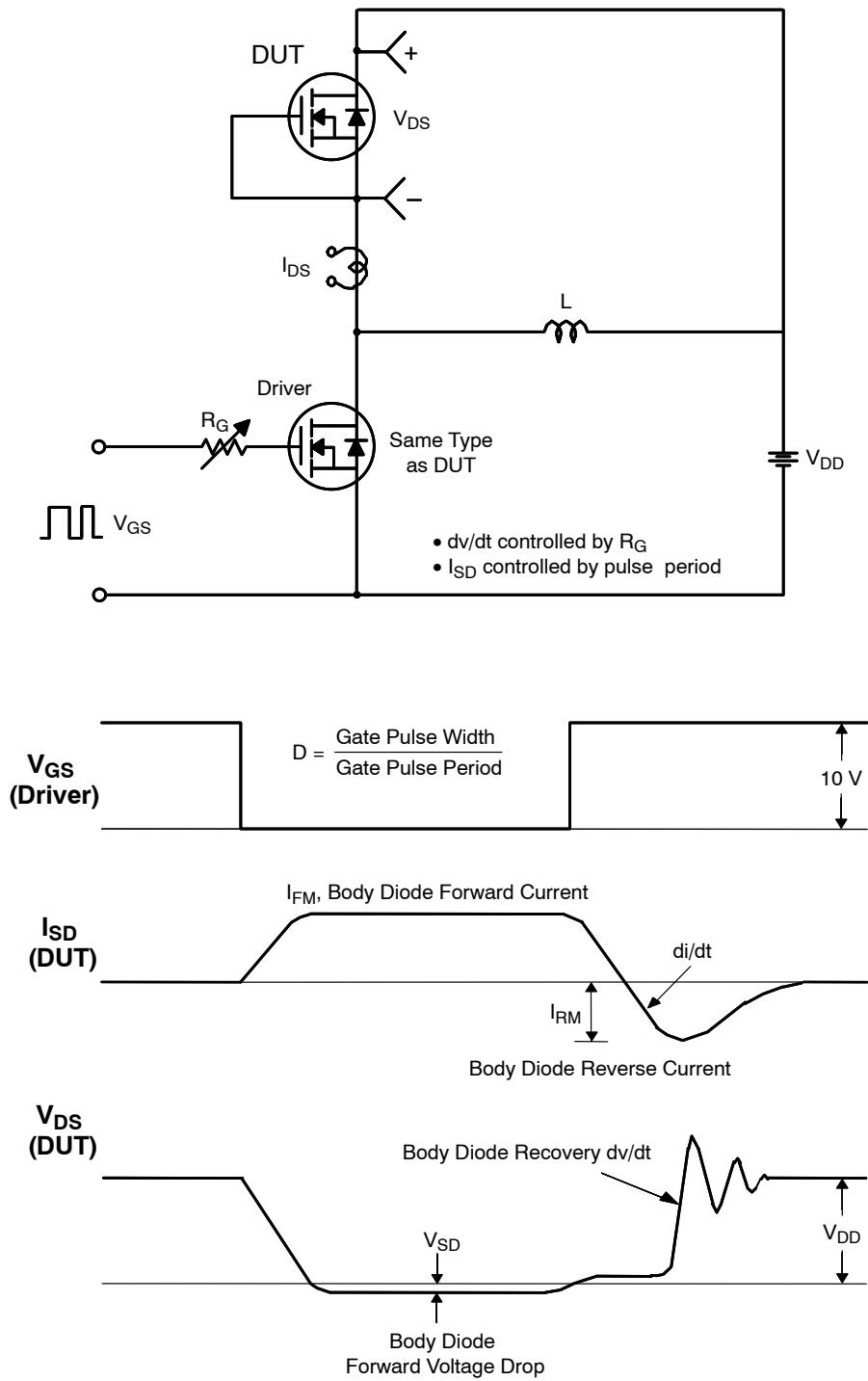
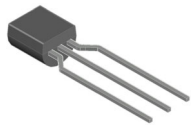


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

MECHANICAL CASE OUTLINE

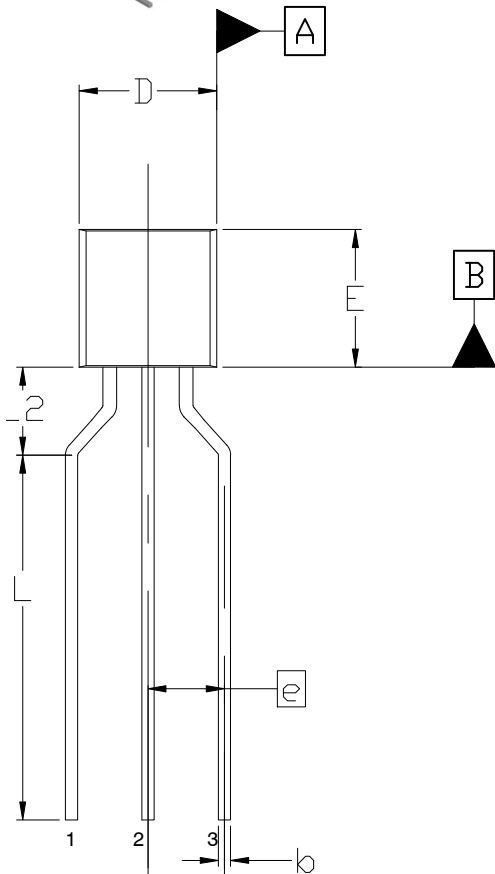
PACKAGE DIMENSIONS

ON Semiconductor®



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CASE 135AV
ISSUE O

DATE 07 JAN 2021



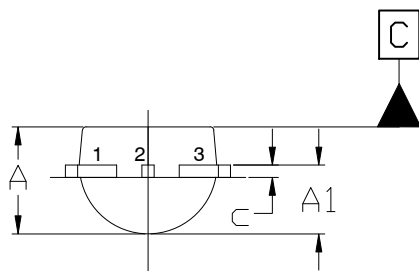
NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, GATE REMAINS AND TIE BAR PROTRUSIONS.

| DIM | MILLIMETERS | | |
|-----|-------------|-------|-------|
| | MIN. | NOM. | MAX. |
| A | 3.05 | 3.60 | 4.19 |
| A1 | 2.13 | 2.50 | 2.88 |
| b | 0.36 | 0.46 | 0.56 |
| c | 0.30 | 0.40 | 0.52 |
| D | 4.32 | 4.75 | 5.20 |
| E | 4.32 | 4.80 | 5.33 |
| e | 2.54 BSC | | |
| L | 10.50 | 11.75 | 13.00 |
| L2 | 2.54 | --- | 3.44 |

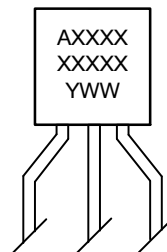


TOP VIEW



END VIEW

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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